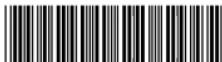


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10560301	CHANG ET AL.
Examiner	Art Unit	
WILLIAM H BEISNER	1775	

SEARCHED

Class	Subclass	Date	Examiner
435	285.2, 173.6	2/24/2011	/WHB/
204	604, 643	2/24/2011	/WHB/
Above	Updated	8/1/2011	/WHB/

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Name Search Performed	2/24/2011	/WHB/
East (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)- See Search History Printout	2/24/2011	/WHB/
Inventor Name Search Updated	8/1/2011/	/WHB/
East (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)- See Search History Printout	8/1/2011	/WHB/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner